

**Search Notes**

Application/Control No.

10/721,376

Examiner

M. Lee

Applicant(s)/Patent under  
Reexamination

ZHOU ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	448-452	6/23/2006	ML
	458, 441		
	442		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/23/2006	ML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner